



TEST SUMMARY

USB TYPE C 24 Pin Connector

(MOLEX P/N: 2024100002)

<u>REVISION:</u>	<u>ECR/ECN INFORMATION:</u>	<u>TITLE:</u>	<u>SHEET No.</u>
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<u>DOCUMENT NUMBER:</u>		<u>CREATED/REVISED</u>	<u>APPROVED BY</u>
TS-202410-002		<i>David Chen</i>	<i>Kim Yang</i>



TEST SUMMARY

1.0 SCOPE:

This test summary covers the USB type C 24 pin receptacle. These results are applicable to the following product: 2024100002.

2.0 PRODUCT DESCRIPTION:

2.1 PRODUCT NAME AND PART NUMBER (S):

Name: USB TYPE C 24 PIN RECEPTACLE.

Part No.: 2024100002 Rev: A.

2.2 DIMENSIONS, MATERIALS, PLATINGS AND MARKINGS

Refer to sales drawing No: PSD2024100002. Rev: A.

2.3 PRODUCT SPECIFICATION TITLE AND DOCUMENT NUMBER

Title: USB TYPE C 24 PIN RECEPTACLE.

Document Number: 2024100002 Rev: A.

3.0 APPLICABLE DOCUMENTS AND SPECIFICATIONS:

3.1 TESTING PROCEDURE AND SEQUENCE

Testing is performed sequentially and is divided into 15 groups.

3.2 OTHER DOCUMENTS AND SPECIFICATIONS

RTS-202410-001 and EIA-364 series standard.

4.0 QUALIFICATION:

Laboratory conditions and sample selection are in accordance with EIA-364 Standard.

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5.0 TEST SEQUENCE:

Description	A	B	C	D	E	F	G	H	I	J	K	L	M	N
Sample Size	5	5	5	5	5	5	5	5	5	5	5	5	5	5
Visual inspection	1,3	1,1 0	1,1 5	1, 10	1,8	1,7	1,7	1,3	1,6	1,6	1,3	1,3	1,3	
LLCR		2,6 ,9	3,1 2	2,4 ,9	2,4 ,7	2,6	2,6		2,5	2,5				
Insulation resistance			14											
Dielectric withstanding voltage			2,1 3											
Contact Capacitance								2						
Temperature rise	2													
Mating force			4,7 ,10											
Un-mating force			5,8 ,11											
Reseating(3X)		5,8		8	6	5	5		4	4				
Durability(50X)		3		3	3	3	3							
Durability(1000X)			6											
Durability(9000X)			9											
Mechanical shock				7										
Radom Vibration				5										
Sine Vibration				6										
Salt Spray						4								
Humidity- Temperature Cycling		7												
High-temperature and humidity										3				
Thermal shock		4												
Temperature life							4							
Low Temperature									3					
Thermal disturbance														
Thermal Cycling					5									
Solderability Test												2		
Solder peel off Strength													2	
IPx8 water proof														1

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TEST SUMMARY

6.0 PERFORMANCE:

Test Group A						
Test Item	Unit	Specification	Max.	Min.	Avg.	Status
Visual inspection	--	No physical damage	No physical damage			Pass
Resistance to Soldering Reflow Heat		No physical damage	No physical damage			Pass
Temperature Rise	°C	30°C Max	17.64	14.68	16.81	Pass
Visual inspection	--	No physical damage	No physical damage			Pass

Test Group B						
Test Item	Unit	Specification	Max.	Min.	Avg.	Status
Visual inspection	--	No physical damage	No physical damage			Pass
Resistance to Soldering Reflow Heat	--	No physical damage	No physical damage			Pass
LLCR	mΩ	40 mΩ Max.	28.14	12.52	17.09	Pass
Durability(50x)	--	No physical damage	No physical damage			Pass
Thermal Shock	--	No physical damage	No physical damage			Pass
Reseating (3X)	--	No physical damage	No physical damage			Pass
LLCR	mΩ	ΔR:10 mΩ Max.	4.16	-15.83	-1.99	Pass
Humidity- Temperature Cycling	--	No physical damage	No physical damage			Pass
Reseating (3X)	--	No physical damage	No physical damage			Pass
LLCR	mΩ	ΔR:10 mΩ Max.	7.15	-12.30	-1.92	Pass
Visual inspection	--	No physical damage	No physical damage			Pass

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6.0 PERFORMANCE:(Continued)

Test Group C						
Test Item	Unit	Specification	Max.	Min.	Avg.	Status
Visual inspection	--	No physical damage	No physical damage			Pass
Resistance to Soldering Reflow Heat		Appearance: No Damage	No Damage			Pass
Dielectric withstanding voltage	--	No breakdown	No breakdown			Pass
LLCR		40 mΩ Max.	21.95	12.98	16.46	Pass
Mating force	N	5~20 N	10.49	8.05	9.63	Pass
Un-mating force	N	8~20 N Min	17.13	15.52	16.32	Pass
Durability 1000 cycles	--	No physical damage	No physical damage			Pass
Mating force	N	5~20 N	13.57	11.26	12.62	Pass
Un-mating force	N	8~20 N	18.45	11.05	13.86	Pass
Durability 9000 cycles	--	No physical damage	No physical damage			Pass
Mating force	N	5~20 N	14.84	9.03	11.81	Pass
Un-mating force	N	6~20 N	15.37	8.22	12.11	Pass
LLCR	mΩ	ΔR:10 mΩ Max.	7.07	-2.40	1.09	Pass
Dielectric withstanding voltage	--	No breakdown	No breakdown			Pass
Insulation resistance	MΩ	100 MΩ Min	2.90x10 ³ MΩ			Pass
Visual inspection	--	No physical damage	No physical damage			Pass

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6.0 PERFORMANCE:(Continued)

Test Group D						
Test Item	Unit	Specification	Max.	Min.	Avg.	Status
Visual inspection	--	No physical damage	No physical damage			Pass
Resistance to Soldering Reflow Heat	--	No physical damage	No physical damage			Pass
LLCR	mΩ	40 mΩ Max.	19.63	11.63	14.99	Pass
Durability(50x)	--	No physical damage	No physical damage			Pass
LLCR	mΩ	ΔR:10 mΩ Max.	7.04	-4.19	1.32	Pass
Random Vibration	us	Discontinuity < 1 us	No Discontinuity			Pass
	--	No physical damage	No physical damage			Pass
Sine Vibration	us	Discontinuity < 1 us	No Discontinuity			Pass
	--	No physical damage	No physical damage			Pass
Mechanical shock	us	Discontinuity < 1 us	No Discontinuity			Pass
	--	No physical damage	No physical damage			Pass
Reseating (3X)	--	No physical damage	No physical damage			Pass
LLCR	mΩ	ΔR:10 mΩ Max.	4.63	-3.70	1.29	Pass
Visual inspection	--	No physical damage	No physical damage			Pass

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6.0 PERFORMANCE:(Continued)

Test Group E						
Test Item	Unit	Specification	Max.	Min.	Avg.	Status
Visual inspection	--	No physical damage	No physical damage			Pass
Resistance to Soldering Reflow Heat	--	No physical damage	No physical damage			Pass
LLCR	mΩ	40 mΩ Max.	18.03	11.46	14.99	Pass
Durability(50x)	--	No physical damage	No physical damage			Pass
LLCR	mΩ	ΔR:10 mΩ Max.	2.30	-2.06	0.35	Pass
Thermal Cycling	--	No physical damage	No physical damage			Pass
Reseating (3X)	--	No physical damage	No physical damage			Pass
LLCR	mΩ	ΔR:10 mΩ Max.	1.79	-1.93	0.28	Pass
Visual inspection	--	No physical damage	No physical damage			Pass

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6.0 PERFORMANCE:(Continued)

Test Group F						
Test Item	Unit	Specification	Max.	Min.	Avg.	Status
Visual inspection	--	No physical damage	No physical damage			Pass
Resistance to Soldering Reflow Heat	--	No physical damage	No physical damage			Pass
LLCR	mΩ	40 mΩ Max.	22.36	12.16	16.07	Pass
Durability(50x)	--	No physical damage	No physical damage			Pass
Salt Spray	--	No physical damage	No physical damage			Pass
Reseating (3X)	--	No physical damage	No physical damage			Pass
LLCR	mΩ	ΔR:10 mΩ Max.	8.97	-5.74	-0.36	Pass
Visual inspection	--	No physical damage	No physical damage			Pass

Test Group G						
Test Item	Unit	Specification	Max.	Min.	Avg.	Status
Visual inspection	--	No physical damage	No physical damage			Pass
Resistance to Soldering Reflow Heat	--	No physical damage	No physical damage			Pass
LLCR	mΩ	40 mΩ Max.	23.86	11.96	16.94	Pass
Durability(50x)	--	No physical damage	No physical damage			Pass
Temperature Life	--	No physical damage	No physical damage			Pass
Reseating (3X)	--	No physical damage	No physical damage			Pass
LLCR	mΩ	ΔR:10 mΩ Max.	3.29	-8.16	-0.72	Pass
Visual inspection	--	No physical damage	No physical damage			Pass

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6.0 PERFORMANCE:(Continued)

Test Group H						
Test Item	Unit	Specification	Max.	Min.	Avg.	Status
Visual inspection	--	No physical damage	No physical damage			Pass
Contact Capacitance	mΩ	2pF Max.	1.16	0.54	0.80	Pass
Visual inspection	--	No physical damage	No physical damage			Pass

Test Group I						
Test Item	Unit	Specification	Max.	Min.	Avg.	Status
Visual inspection	--	No physical damage	No physical damage			Pass
Resistance to Soldering Reflow Heat	--	No physical damage	No physical damage			Pass
LLCR	mΩ	40 mΩ Max.	23.96	12.45	17.02	Pass
Low Temperature	--	No physical damage	No physical damage			Pass
Reseating (3X)	--	No physical damage	No physical damage			Pass
LLCR	mΩ	ΔR:10 mΩ Max.	0.95	-7.89	-1.44	Pass
Visual inspection	--	No physical damage	No physical damage			Pass

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6.0 PERFORMANCE:(Continued)

Test Group J						
Test Item	Unit	Specification	Max.	Min.	Avg.	Status
Visual inspection	--	No physical damage	No physical damage			Pass
Resistance to Soldering Reflow Heat	--	No physical damage	No physical damage			Pass
LLCR	mΩ	40 mΩ Max.	32.55	11.69	15.81	Pass
High Temp& Humidity	--	No physical damage	No physical damage			Pass
Reseating (3X)	--	No physical damage	No physical damage			Pass
LLCR	mΩ	ΔR:10 mΩ Max.	3.37	-13.80	0.38	Pass
Visual inspection	--	No physical damage	No physical damage			Pass

Test Group K						
Test Item	Unit	Specification	Max.	Min.	Avg.	Status
Visual inspection	--	No physical damage	No physical damage			Pass
Resistance to Soldering Reflow Heat	--	No physical damage	No physical damage			Pass
LLCR	mΩ	40 mΩ Max.	18.12	12.05	15.35	Pass
Durability(50x)	--	No physical damage	No physical damage			Pass
LLCR	mΩ	ΔR:10 mΩ Max.	0.47	-2.31	-0.34	Pass
Thermal Disturbance	--	No physical damage	No physical damage			Pass
Reseating (3X)	--	No physical damage	No physical damage			Pass
LLCR	mΩ	ΔR:10 mΩ Max.	5.32	-1.31	0.87	Pass
Visual inspection	--	No physical damage	No physical damage			Pass

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Test Group L						
Test Item	Unit	Specification	Max.	Min.	Avg.	Status
Visual inspection	--	No physical damage	No physical damage			Pass
Solderability	--	>95% coverage	>95% coverage			Pass
Visual inspection	--	No physical damage	No physical damage			Pass

Test Group M						
Test Item	Unit	Specification	Max.	Min.	Avg.	Status
Visual inspection	--	No physical damage	No physical damage			Pass
Solder peel off strength	N	Push 50 N in 10 seconds	No physical damage			Pass
		70 N min	144.3	102.4	123.3	Pass
Visual inspection	--	No physical damage	No physical damage			Pass

Test Group N						
Test Item	Unit	Specification	Max.	Min.	Avg.	Status
IPX8 water proof	--	No water leakage	No water leakage			Pass

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7.0 TEST EQUIPMENT:

S/N	DESCRIPTION	MANUFACTURING	MODEL
1	Milliohm meter	HP	4338B
2	Max Intelligent Load Tester	JAPAN INSTRUMENT	Max-1KN-H
3	High Resistance Meter	HP	4339A
4	Withstanding Voltage /Insulation Analyzer	EXTECH	CWI-703
5	Precision LCR Meter	HP	4284A
6	Resistance to Soldering Heat	BTU	PYRAMAX 150N*5
7	Vibration Test System	KING DESIGN	EM-600F2K-50N120
8	Mechanical Shock Tester	Xunke	BIS50
9	Discontinuous Time Detector	NACMAN	NM-10A
10	Thermal Shock Chamber	VOTSCH	VT7012 S2
11	Temperature & Humidity Chamber	VOTSCH	VC 7015
12	Hot Air Rapid Drying Oven	HERAEUS	UT6060
13	DC Power Supply	AGILENT	E 3633A
14	DC Power Supply	HP	E3614A
15	Source Meter	Agilent 2400	2400
16	Data Acquisition System	KEITHLEY	2700
17	Solder Pot	RHESCA	SAT-5000
18	Durability Machine	LIGE	N/A

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8.0 REVISION HISTORY:

REV.	DESCRIPTIONS	DATE	EC No.	BY
A	Release	2017/02/06		David Chen

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